Search Notes



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Examiner

Keefer, Michael E

Applicant(s)/Patent Under Reexamination

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SEARCHED

Class	Subclass	Date	Examiner
709	235 (Updated 10/24/2007)	7/3/2007	MEK
718	102	10/24/2007	MEK
370	237	10/25/2007	MEK

SEARCH NOTES

Search Notes	Date	Examiner
EAST Search	7/6/2007	MEK
Consulted Examiner Joshua Joo	7/3/2007	MEK
Consulted Examiner Adam Weintrop	7/5/2007	MEK
Consulted Examiner Dustin Nguyen	10/23/2007	MEK
Consulted Examiner Kenneth Tang	10/23/2007	MEK
Consulted Primary Examiner Lewis Bullock	10/25/2007	MEK

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
709	235	10/25/2007	MEK
370	237	10/25/2007	MEK
718	102	10/25/2007	MEK

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